## BRISTOL INSTRUMENTS

## LASER WAVELENGTH METER

### 871 Series



# Fast, accurate, and reliable wavelength measurment of pulsed and CW lasers

The 871 Series Laser Wavelength Meter from Bristol Instruments uses a proven Fizeau etalon design to measure the wavelength of pulsed and CW lasers to an accuracy as high as  $\pm$  0.0001 nm. The system generates a spatial interferogram that is detected by a fast photodetector array. An on-board digital signal processor quickly converts the interferometric information to wavelength resulting in a sustained measurement rate as high as 1 kHz.

Two versions of the 871 Laser Wavelength Meter are available. The model 871A is the most precise, providing an accuracy of  $\pm$  0.2 parts per million ( $\pm$  60 MHz at 1000 nm). For experiments that are less exacting, the model 871B is a lower-priced alternative with an accuracy of  $\pm$  0.75 parts per million ( $\pm$  225 MHz at 1000 nm). Automatic calibration with a built-in wavelength standard guarantees this performance to ensure the most meaningful experimental results.

#### **Key Features:**

- Wavelength accuracy up to ± 0.0001 nm.
- Automatic calibration with a built-in wavelength standard.
- Operation available from 375 nm to 2.5 µm.
- Sustained measurement rate of 1 kHz.
- Convenient pre-aligned fiber-optic input.
- Asynchronous operation with automatic pulse detection.
- Straightforward operation with a PC using USB or Ethernet.
- Display software provided to control measurement parameters and report wavelength data.
- Built-in PID controller for precise laser stabilization.
- Automatic data reporting using custom or LabVIEW programming eliminates the need for a dedicated PC.
- Convenient tablet/smartphone application reports measurement data anywhere in the laboratory.
- Five-year warranty covers all parts and labor.

IODEL	871A	871B
	Pulsed and CW	
		N//C 275_ 4400
Range	VIS: 375 - 1100 nm NIR: 630 - 1700 nm	VIS: 375 - 1100 nm NIR: 630 - 1700 nm NIR2: 1000 - 2500 nm
Accuracy <sup>1, 2, 3</sup>	± 0.2 ppm (single-mode fiber) ± 0.0002 nm @ 1000 nm ± 60 MHz @ 300,000 GHz	± 0.75 ppm (single-mode fiber) ± 0.0008 nm @ 1000 nm ± 225 MHz @ 300,000 GHz ± 1 ppm (multi-mode graded-index fiber ≤ 62.5 µm diameter) ± 0.001 nm @ 1000 nm ± 300 MHz @ 300,000 GHz
Repeatability <sup>4,5</sup>	± 0.0075 ppm ± 0.0075 pm @ 1000 nm ± 2.25 MHz @ 300,000 GHz	± 0.0125 ppm ± 0.0125 pm @ 1000 nm ± 3.75 MHz @ 300,000 GHz
Calibration <sup>6</sup>	Automatic with built-in wavelength standard	
Display Resolution	9 digits	8 digits
Units <sup>7</sup>	nm, μm, cm <sup>-1</sup> , GHz, THz	
PTICAL INPUT SIGNAL		
Maximum Bandwidth (FWHM)	1 GHz	10 GHz
Minimum Input <sup>8, 9, 10, 11</sup>	VIS: 3 - 300 nJ NIR: 50 - 600 nJ	VIS: 3 - 300 nJ NIR: 30 - 600 nJ NIR2: 50 - 600 nJ
IEASUREMENT RATE	1 kHz	
NPUTS/OUTPUTS		
Optical Input <sup>12, 13</sup>	Pre-aligned FC/PC fiber connector (optional free beam-to-fiber coupler)	
Instrument Interface	USB and Ethernet interface with Windows-based display program, and browser-based display application Streaming via RS-422 (internal or external TTL trigger) Internal data storage for up to 1 million measurements Library of commands (SCPI) for custom and LabVIEW programming using any PC operating system PID controller (± 5 V output)	
OMPUTER REQUIREMENTS 14	PC running Windows 7, 8, or 10, 1 GB available RAM, USB 2.0 (or later) port, monitor, pointing device	
NVIRONMENTAL <sup>®</sup>		
Warm-Up Time	< 15 minutes	
Temperature   Pressure   Humidity	+15°C to +30°C (-10°C to +70°C storage)   500 − 900 mm Hg   $\leq$ 90% R.H. at + 40°C (no condensation)	
DIMENSIONS AND WEIGHT		
Dimensions (H x W x D)	3.5" x 17.0" x 15.0" (89 mm x 432 mm x 381 mm)	
Weight	17 lbs (7.65 kg)	
OWER REQUIREMENTS	90 - 264 VAC, 47 - 63 Hz, 50 VA max	
VARRANTY	5 Years (parts and labor)	
Defined as measurement uncertainty, or maximum we Traceable to accepted physical standards. Single-mode input fiber must have single-mode perfo Standard deviation for a 1 minute measurement perio twice the 1 minute specification. Wavelength resolution is approximately two times rep For VIS version, stabilized single-frequency HeNe lase Data in units of nm, µm, and cm <sup>-1</sup> are given as vacuum Characteristic performance, but non-warranted. Required minimum energy from a single laser pulse. G the integration of a greater number of laser pulses.	avelength error, with a confidence level of ≥ 99.7%. rmance at the wavelength of the laser under test. d after the instrument has reached thermal equilibrium. Standard devi peatability. er. For NIR and NIR2 versions, laser diode locked to acetylene absorptic	ation for a 10 minute period is about on (NIST Special Publication 260-133).

Bristol Instruments reserves the right to change the specifications as may be required to permit improvements in the design of its products. Specifications are subject to change without notice.